May 13, 2009

DS25CP104A / DS25CP114

3.125 Gbps 4x4 LVDS Crosspoint Switch with Transmit Pre-Emphasis and Receive Equalization

General Description

The DS25CP104A and DS25CP114 are 3.125 Gbps 4x4 LVDS crosspoint switches optimized for high-speed signal routing and switching over lossy FR-4 printed circuit board backplanes and balanced cables. Fully differential signal paths ensure exceptional signal integrity and noise immunity. The non-blocking architecture allows connections of any input to any output or outputs. The switch configuration can be accomplished via external pins or the System Management Bus (SMBus) interface.

The DS25CP104A and DS25CP114 feature four levels (Off, Low, Medium, High) of transmit pre-emphasis (PE) and four levels (Off, Low, Medium, High) of receive equalization (EQ) settable via the SMBus interface. Off and Medium PE levels and Off and Low EQ levels are settable with the external pins. In addition, the SMBus circuitry enables the loss of signal ($\overline{\text{LOS}}$) monitors that can inform a system of the presence of an open inputs condition (e.g. disconnected cable).

Wide input common mode range allows the switch to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires a minimal space on the board while the flow-through pinout allows easy board layout. On the DS25CP104A each differential input and output is internally terminated with a 100Ω resistor to lower return losses, reduce component count and further minimize board space. For added design flexibility the 100Ω input terminations on the DS25CP114 have been eliminated. This enables a designer to build custom crosspoint configurations and distribution circuits that require a limited multidrop signaling topology.

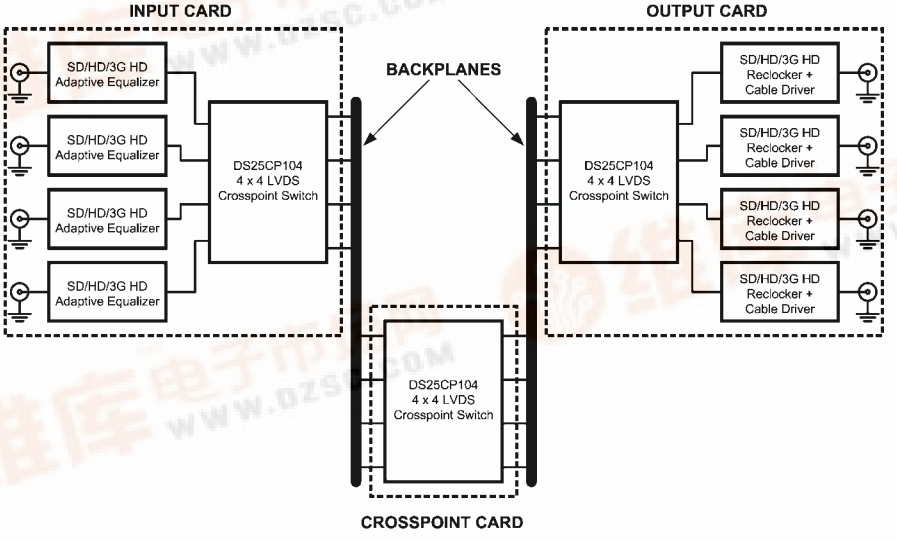
Features

- DC - 3.125 Gbps low jitter, low skew, low power operation
- Pin and SMBus configurable, fully differential, non-blocking architecture
- Pin (two levels) and SMBus (four levels) selectable pre-emphasis and equalization eliminate ISI jitter
- Wide Input Common Mode Range enables easy interface to CML and LVPECL drivers
- $\overline{\text{LOS}}$ circuitry detects open inputs fault condition
- On-chip 100Ω input and output termination minimizes insertion and return losses, reduces component count and minimizes board space. The DS25CP114 eliminates the on-chip input termination for added design flexibility.
- 8 kV ESD on LVDS I/O pins protects adjoining components
- Small 6 mm x 6 mm LLP-40 space saving package

Applications

- SD/HD/3G HD SDI Routers
- OC-48 / STM-16
- InfiniBand and FireWire

Typical Application



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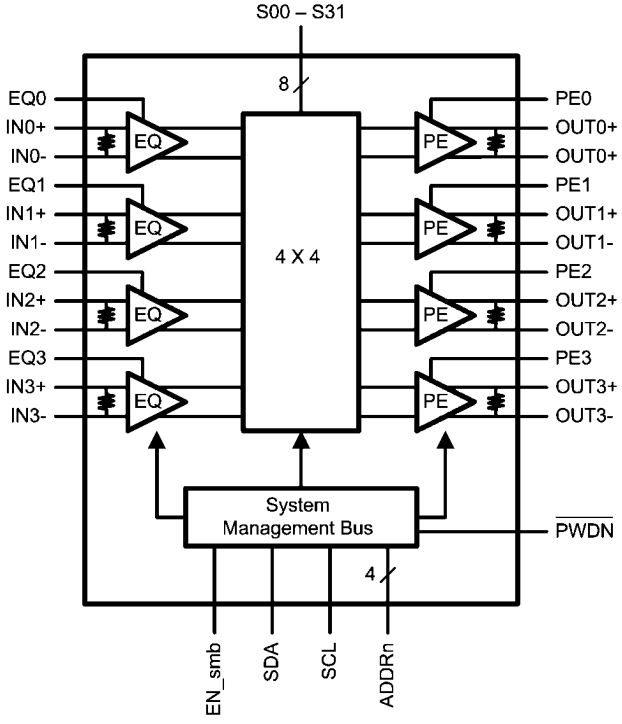
Device Information

Device	Function	Termination Option	Available Signal Conditioning
DS25CP104A	4x4 Crosspoint Switch	Internal 100Ω for LVDS inputs	4 Levels: PE and EQ
DS25CP114	4x4 Crosspoint Switch	None: Requires external termination	4 Levels : PE and EQ

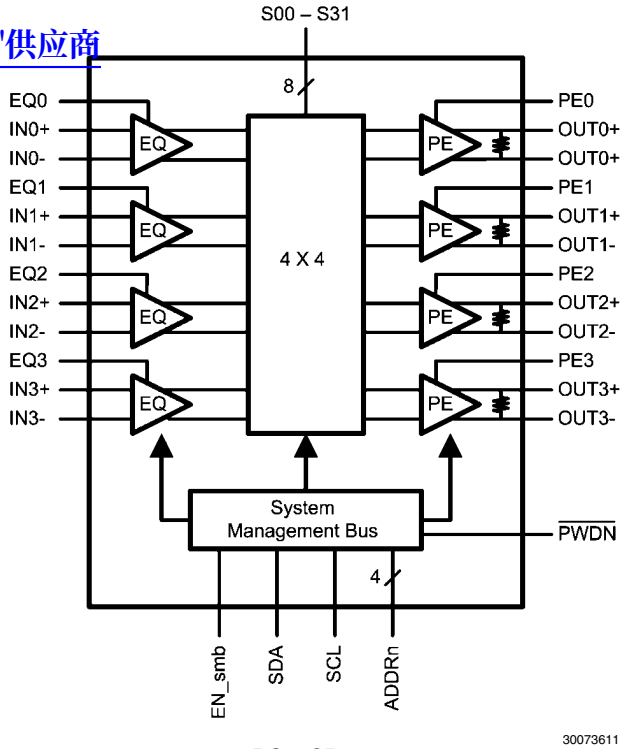
Ordering Information

NSID	Package	Tape & Reel QTY	Package Number
DS25CP104ATSQ	40 Lead LLP Package	250	SQA40A
DS25CP104ATSQX	40 Lead LLP Package	2500	SQA40A
DS25CP114TSQ	40 Lead LLP Package	250	SQA40A
DS25CP114TSQX	40 Lead LLP Package	2500	SQA40A

Block Diagrams

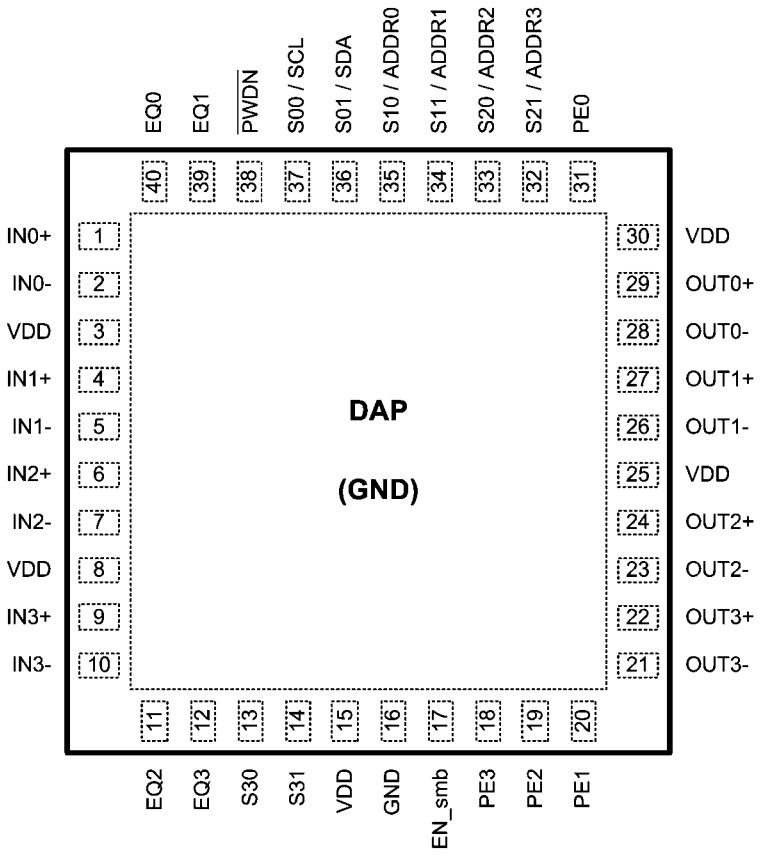


DS25CP104A



DS25CP114

Connection Diagram



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DS25CP104A / DS25CP114 Pin Diagram

Pin Descriptions

Pin Name	Pin Number	I/O, Type	Pin Description
IN0+, IN0- , IN1+, IN1-, IN2+, IN2-, IN3+, IN3-	1, 2, 4, 5, 6, 7, 9, 10	I, LVDS	Inverting and non-inverting high speed LVDS input pins. These 4 input pairs have a 100 Ohm differential input termination on the CP104A device. The CP114 eliminates the input termination for added design flexibility.
OUT0+, OUT0-, OUT1+, OUT1-, OUT2+, OUT2-, OUT3+, OUT3-	29, 28, 27, 26, 24, 23, 22, 21	O, LVDS	Inverting and non-inverting high speed LVDS output pins. Each output pair has an internal 100 Ohm termination to improve device return loss characteristics.
EQ0, EQ1, EQ2, EQ3	40, 39, 11, 12	I, LVCMOS	Receive equalization level select pins. These pins are functional regardless of the EN_smb pin state.
PE0, PE1, PE2, PE3	31, 20, 19, 18	I, LVCMOS	Transmit pre-emphasis level select pins. These pins are functional regardless of the EN_smb pin state.
EN_smb	17	I, LVCMOS	System Management Bus (SMBus) enable pin. The pin has an internal pull down. When the pin is set to a [1], the device is in the SMBus mode. All SMBus registers are reset when this pin is toggled. There is a 20k pulldown device on this pin.
S00/SCL	37	I, LVCMOS	For EN_smb = [0], these pins select which LVDS input is routed to the OUT0. In the SMBus mode, when the EN_smb = [1], these pins are SMBus clock input and data input pins respectively.
S01/SDA	36	I/O, LVCMOS	
S10/ADDR0, S11/ADDR1	35, 34	I, LVCMOS	For EN_smb = [0], these pins select which LVDS input is routed to the OUT1. In the SMBus mode, when the EN_smb = [1], these pins are the User-Set SMBus Slave Address inputs.
S20/ADDR2, S21/ADDR3	33, 32	I, LVCMOS	For EN_smb = [0], these pins select which LVDS input is routed to the OUT2. In the SMBus mode, when the EN_smb = H, these pins are the User-Set SMBus Slave Address inputs.
S30, S31	13, 14	I, LVCMOS	For EN_smb = [0], these pins select which LVDS input is routed to the OUT3. In the SMBus mode, when the EN_smb = [1], these pins are non-functional and should be tied to either logic H or L.
$\overline{\text{PWDN}}$	38	I, LVCMOS	For EN_smb = [0], this is the power down pin. When the $\overline{\text{PWDN}}$ is set to a [0], the device is in the power down mode. The SMBus circuitry can still be accessed provided the EN_smb pin is set to a [1]. In the SMBus mode, the device is powered up by either setting the $\overline{\text{PWDN}}$ pin to [1] **OR** by writing a [1] to the Control Register D[7] bit ($\overline{\text{SoftPWDN}}$). The device will be powered down by setting the $\overline{\text{PWDN}}$ pin to [0] **AND** by writing a [0] to the Control Register D[7] bit ($\overline{\text{SoftPWDN}}$).
VDD	3, 8, 15,25, 30	Power	Power supply pins.
GND	16, DAP	Power	Ground pin and a pad (DAP - die attach pad).

Note: Center DAP connection must be made to GND for optimum electrical and thermal performance.

Absolute Maximum Ratings (Note 4)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Supply Voltage	−0.3V to +4V
LVCMOS Input Voltage	−0.3V to (V_{CC} + 0.3V)
LVCMOS Output Voltage	−0.3V to (V_{CC} + 0.3V)
LVDS Input Voltage	−0.3V to +4V
LVDS Differential Input Voltage (DS25CP104A)	1.0V
LVDS Differential Input Voltage (DS25CP114)	V_{CC} + 0.6V
LVDS Output Voltage	−0.3V to (V_{CC} + 0.3V)
LVDS Differential Output Voltage	0V to 1.0V
LVDS Output Short Circuit Current Duration	5 ms
Junction Temperature	+150°C
Storage Temperature Range	−65°C to +150°C
Lead Temperature Range	
Soldering (4 sec.)	+260°C
Maximum Package Power Dissipation at 25°C	
SQA Package	4.65W
Derate SQA Package	37.2 mW/°C above +25°C
Package Thermal Resistance	
θ_{JA}	+26.9°C/W
θ_{JC}	+3.8°C/W
ESD Susceptibility	
HBM (Note 1)	≥8 kV
MM (Note 2)	≥250V
CDM (Note 3)	≥1250V

Note 1: Human Body Model, applicable std. JESD22-A114C

Note 2: Machine Model, applicable std. JESD22-A115-A

Note 3: Field Induced Charge Device Model, applicable std. JESD22-C101-C

Recommended Operating Conditions

	Min	Typ	Max	Units
Supply Voltage (V_{CC})	3.0	3.3	3.6	V
Receiver Differential Input Voltage (V_{ID}) (DS25CP104A only)	0		1	V
Operating Free Air Temperature (T_A)	−40	+25	+85	°C
SMBus (SDA, SCL)			3.6	V

DC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. (Notes 5, 6, 8)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
LVCMOS DC SPECIFICATIONS							
V_{IH}	High Level Input Voltage			2.0		V_{CC}	V
V_{IL}	Low Level Input Voltage			GND		0.8	V
I_{IH}	High Level Input Current	V_{IN} = 3.6V, V_{CC} = 3.6V			0	±10	µA
			EN_smb pin	40	175	250	µA
I_{IL}	Low Level Input Current	V_{IN} = GND, V_{CC} = 3.6V			0	±10	µA
V_{CL}	Input Clamp Voltage	I_{CL} = −18 mA, V_{CC} = 0V			−0.9	−1.5	V
V_{OL}	Low Level Output Voltage	I_{OL}= 4 mA	SDA pin			0.4	V
LVDS INPUT DC SPECIFICATIONS							
V_{ID}	Input Differential Voltage(Note 9)	V_{CM} = +0.05V or V_{CC}-0.05V		0		1	V
V_{TH}	Differential Input High Threshold				0	+100	mV
V_{TL}	Differential Input Low Threshold			−100	0		mV
V_{CMR}	Input Common Mode Voltage Range	V_{ID} = 100 mV		0.05		V_{CC} - 0.05	V
I_{IN}	Input Current(Note 7)	V_{IN} = +3.6V or 0V, V_{CC} = 3.6V or 0V			±1	±10	µA
C_{IN}	Input Capacitance	Any LVDS Input Pin to GND			1.7		pF
R_{IN}	Input Termination Resistor(Note 10)	Between IN+ and IN-			100		Ω

Symbol	Parameter	Conditions	Min	Typ	Max	Units
LVDS OUTPUT DC SPECIFICATIONS						
V_{OD}	Differential Output Voltage	R_L = 100Ω	250	350	450	mV
ΔV_{OD}	Change in Magnitude of V_{OD} for Complimentary Output States		-35		35	mV
V_{OS}	Offset Voltage	R_L = 100Ω	1.05	1.2	1.375	V
ΔV_{OS}	Change in Magnitude of V_{OS} for Complimentary Output States		-35		35	mV
I_{OS}	Output Short Circuit Current (Note 11)	OUT to GND		-35	-55	mA
		OUT to V_{CC}		7	55	mA
C_{OUT}	Output Capacitance	Any LVDS Output Pin to GND		1.2		pF
R_{OUT}	Output Termination Resistor	Between OUT+ and OUT-		100		Ω
SUPPLY CURRENT						
I_{CC1}	Supply Current	$\overline{PWDN}$ = 0		40	50	mA
I_{CC2}	Supply Current	$\overline{PWDN}$ = 1 PE = Off, EQ = Off Broadcast (1:4) Mode		145	175	mA
I_{CC3}	Supply Current	$\overline{PWDN}$ = 1 PE = Off, EQ = Off Quad Buffer (4:4) Mode		157	190	mA

Note 4: "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions.

Note 5: The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

Note 6: Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except V_{OD} and ΔV_{OD}.

Note 7: I_{IN} is applied to both pins of the LVDS input pair at the same time.

Note 8: Typical values represent most likely parametric norms for V_{CC} = +3.3V and T_A = +25°C, and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

Note 9: Input Differential Voltage (V_{ID}) The DS25CP104A limits input amplitude to 1 volt. The DS25CP114 supports any V_{ID} within the supply voltage to GND range.

Note 10: Input Termination Resistor (R_{IN}) The DS25CP104A provides an integrated 100 ohm input termination for each high speed LVDS pair. The DS25CP114 eliminates this internal termination.

Note 11: Output short circuit current (I_{OS}) is specified as magnitude only, minus sign indicates direction only.

AC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. (Notes 12, 13)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
LVDS OUTPUT AC SPECIFICATIONS (Note 14)							
t_{PLHD}	Differential Propagation Delay Low to High	R_L = 100Ω			480	650	ps
t_{PHLD}	Differential Propagation Delay High to Low				460	650	ps
t_{SKD1}	Pulse Skew $\lvert t_{PLHD} - t_{PHLD} \rvert$, (Note 15)				20	100	ps
t_{SKD2}	Channel to Channel Skew , (Note 16)				40	125	ps
t_{SKD3}	Part to Part Skew , (Note 17)				50	200	ps
t_{LHT}	Rise Time	R_L = 100Ω			80	150	ps
t_{HLT}	Fall Time				80	150	ps
t_{ON}	Power Up Time	Time from $\overline{PWDN}$ =LH to OUTn active			6	20	µs
t_{OFF}	Power Down Time	Time from $\overline{PWDN}$ =HL to OUTn inactive			8	25	ns
t_{SEL}	Select Time	Time from Sn =LH or HL to new signal at OUTn			8	12	ns
JITTER PERFORMANCE WITH EQ = Off, PE = Off (Note 14)(***Figure 5***)							
t_{RJ1}	Random Jitter (RMS Value) No Test Channels (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2}			1.5625 GHz		0.5	1.1	ps
t_{DJ1}	Deterministic Jitter (Peak to Peak) No Test Channels (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		10	22	ps
t_{DJ2}			3.125 Gbps		10	27	ps
t_{TJ1}	Total Jitter (Peak to Peak) No Test Channels (Note 20)	V_{ID} = 350 mV V_{CM} = 1.2V PRBS-23 (NRZ)	2.5 Gbps		0.07	0.11	UI_{P-P}
t_{TJ2}			3.125 Gbps		0.13	0.16	UI_{P-P}

Symbol	Parameter	Conditions		Min	Typ	Max	Units
JITTER PERFORMANCE WITH EQ = Off, PE = Low(Note 14) (***Figure 6 Figure 9***)							
t_{RJ1A}	Random Jitter (RMS Value) Test Channels A (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2A}			1.5625 GHz		0.5	1.1	ps
t_{DJ1A}	Deterministic Jitter (Peak to Peak) Test Channels A (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		10	22	ps
t_{DJ2A}			3.125 Gbps		10	27	ps
JITTER PERFORMANCE WITH EQ = Off, PE = Medium (Note 14) (***Figure 6 Figure 9***)							
t_{RJ1B}	Random Jitter (RMS Value) Test Channels B (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2B}			1.5625 GHz		0.5	1.1	ps
t_{DJ1B}	Deterministic Jitter (Peak to Peak) Test Channels B (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		12	30	ps
t_{DJ2B}			3.125 Gbps		12	30	ps
t_{TJ1B}	Total Jitter (Peak to Peak) Test Channels B (Note 20)	V_{ID} = 350 mV V_{CM} = 1.2V PRBS-23 (NRZ)	2.5 Gbps		0.08	0.10	UI_{P-P}
t_{TJ2B}			3.125 Gbps		0.10	0.15	UI_{P-P}
JITTER PERFORMANCE WITH EQ = Off, PE = High (Note 14) (***Figures 6, 9***)							
t_{RJ1C}	Random Jitter (RMS Value) Test Channels C (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2C}			1.5625 GHz		0.5	1.1	ps
t_{DJ1C}	Deterministic Jitter (Peak to Peak) Test Channels C (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		30	60	ps
t_{DJ2C}			3.125 Gbps		30	65	ps

Symbol	Parameter	Conditions		Min	Typ	Max	Units
JITTER PERFORMANCE WITH PE = Off, EQ = Low (Note 14) (***Figure 7 Figure 9***)							
t_{RJ1D}	Random Jitter (RMS Value) Test Channels D (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2D}			1.5625 GHz		0.5	1.1	ps
t_{DJ1D}	Deterministic Jitter (Peak to Peak) Test Channels D (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		20	40	ps
t_{DJ2D}			3.125 Gbps		20	40	ps
t_{TJ1D}	Total Jitter (Peak to Peak) Test Channels D (Note 20)	V_{ID} = 350 mV V_{CM} = 1.2V PRBS-23 (NRZ)	2.5 Gbps		0.08	0.15	UI_{P-P}
t_{TJ2D}			3.125 Gbps		0.09	0.20	UI_{P-P}
JITTER PERFORMANCE WITH PE = Off, EQ = Medium (Note 14) (***Figures 7, 9***)							
t_{RJ1E}	Random Jitter (RMS Value) Test Channels E (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2E}			1.5625 GHz		0.5	1.1	ps
t_{DJ1E}	Residual Deterministic Jitter (Peak to Peak) Test Channels E (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		35	60	ps
t_{DJ2E}			3.125 Gbps		28	55	ps
JITTER PERFORMANCE WITH PE = Off, EQ = High (Note 14) (***Figures 7, 9***)							
t_{RJ1F}	Random Jitter (RMS Value) Test Channels F (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		1.3	1.8	ps
t_{RJ2F}			1.5625 GHz		1.4	2.4	ps
t_{DJ1F}	Residual Deterministic Jitter (Peak to Peak) Test Channels F (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		30	75	ps
t_{DJ2F}			3.125 Gbps		35	90	ps
JITTER PERFORMANCE WITH PE = Medium, EQ = Low (Note 14) (***Figures 7, 9***)							
t_{RJ1G}	Random Jitter (RMS Value) Input Test Channels D Output Test Channels B (Note 18)	V_{ID} = 350 mV V_{CM} = 1.2V Clock (RZ)	1.25 GHz		0.5	1.1	ps
t_{RJ2G}			1.5625 GHz		0.5	1.1	ps
t_{DJ1G}	Deterministic Jitter (Peak to Peak) Input Test Channels D Output Test Channels B (Note 19)	V_{ID} = 350 mV V_{CM} = 1.2V K28.5 (NRZ)	2.5 Gbps		25		ps
t_{DJ2G}			3.125 Gbps		20		ps

Symbol	Parameter	Conditions	Min	Typ	Max	Units
SMBus AC SPECIFICATIONS						
f_{SMB}	SMBus Operating Frequency		10		100	kHz
t_{BUF}	Bus free time between Stop and Start Conditions		4.7			µs
$t_{HD:SDA}$	Hold time after (Repeated) Start Condition. After this period, the first clock is generated.		4.0			µs
$t_{SU:SDA}$	Repeated Start Condition setup time.		4.7			µs
$t_{SU:SDO}$	Stop Condition setup time		4.0			µs
$t_{HD:DAT}$	Data hold time		300			ns
$t_{SU:DAT}$	Data setup time		250			ns
$t_{TIMEOUT}$	Detect clock low timeout		25		35	ms
t_{LOW}	Clock low period		4.7			µs
t_{HIGH}	Clock high period		4.0		50	µs
t_{POR}	Time in which a device must be operational after power-on reset				500	ms

Note 12: The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

Note 13: Typical values represent most likely parametric norms for V_{CC} = +3.3V and T_A = +25°C, and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

Note 14: Specification is guaranteed by characterization and is not tested in production.

Note 15: t_{SKD1}, $|t_{PLHD} - t_{PHLD}|$, Pulse Skew, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.

Note 16: t_{SKD2}, Channel to Channel Skew, is the difference in propagation delay (t_{PLHD} or t_{PHLD}) among all output channels in Broadcast mode (any one input to all outputs).

Note 17: t_{SKD3}, Part to Part Skew, is defined as the difference between the same signal path of any two devices running at the same V_{CC} and within 5°C of each other within the operating temperature range.

Note 18: Measured on a clock edge with a histogram and an acummulation of 1500 histogram hits. Input stimulus jitter is subtracted geometrically.

Note 19: Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is subtracted algebraically.

Note 20: Measured on an eye diagram with a histogram and an acummulation of 3500 histogram hits. Input stimulus jitter is subtracted.

DC Test Circuits

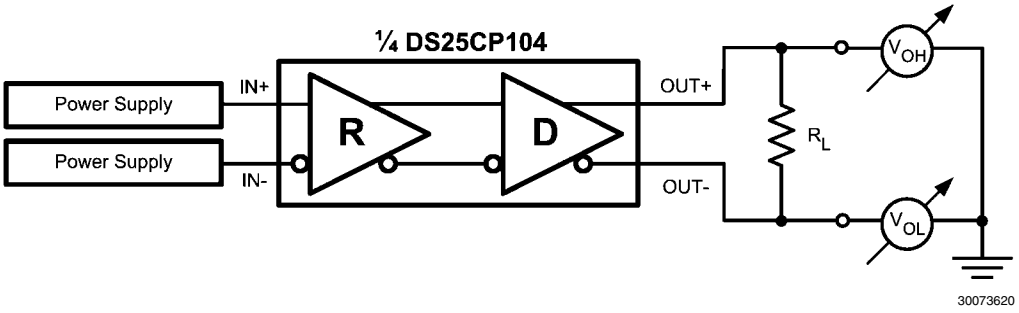


FIGURE 1. Differential Driver DC Test Circuit

AC Test Circuits and Timing Diagrams

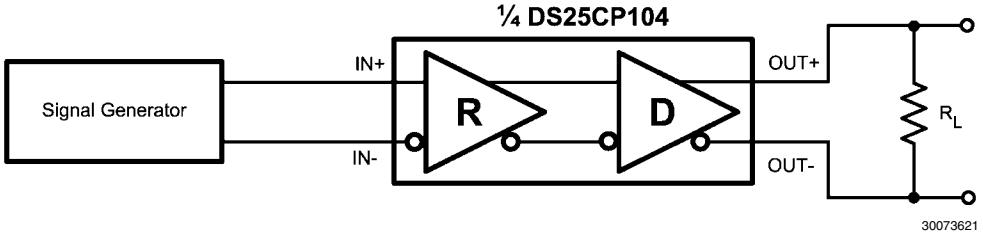


FIGURE 2. Differential Driver AC Test Circuit

Note: DS25CP114 requires external 100Ω input termination.

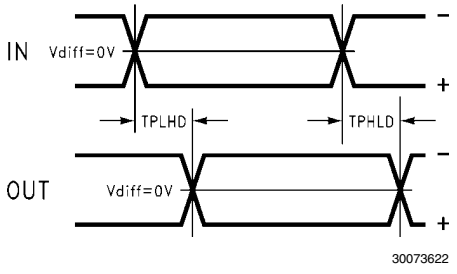


FIGURE 3. Propagation Delay Timing Diagram

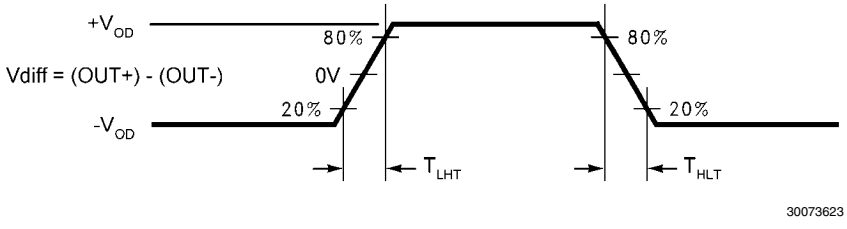


FIGURE 4. LVDS Output Transition Times

Pre-Emphasis and Equalization Test Circuits

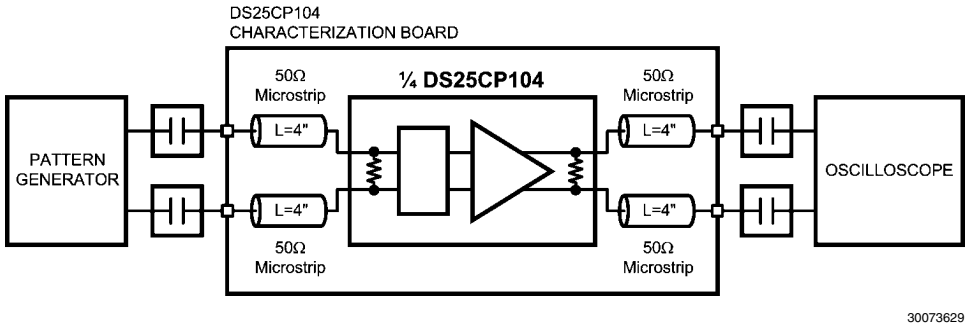


FIGURE 5. Jitter Performance Test Circuit

Note: DS25CP114 requires external 100Ω input termination.

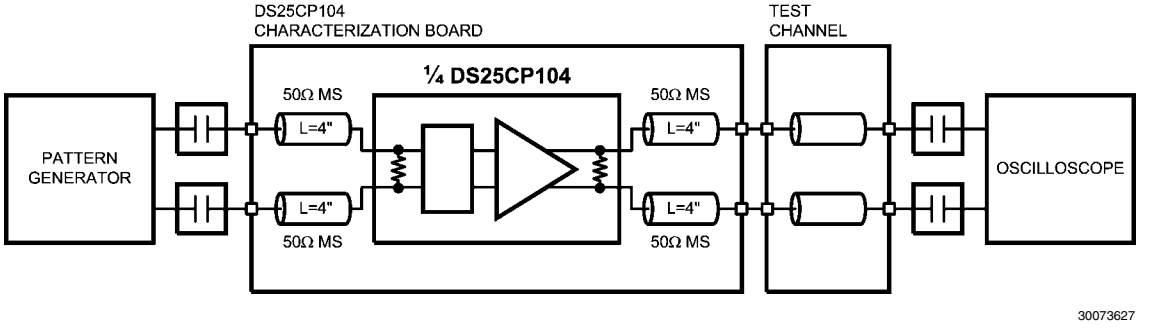


FIGURE 6. Pre-Emphasis Performance Test Circuit

Note: DS25CP114 requires external 100Ω input termination.

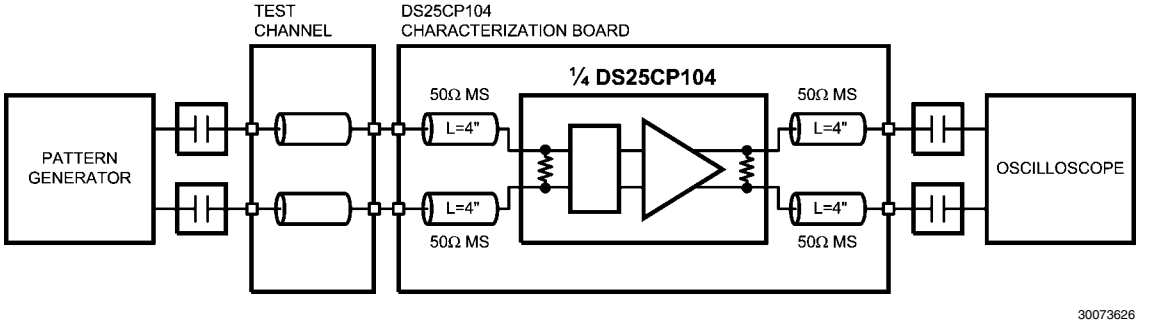


FIGURE 7. Equalization Performance Test Circuit

Note: DS25CP114 requires external 100Ω input termination.

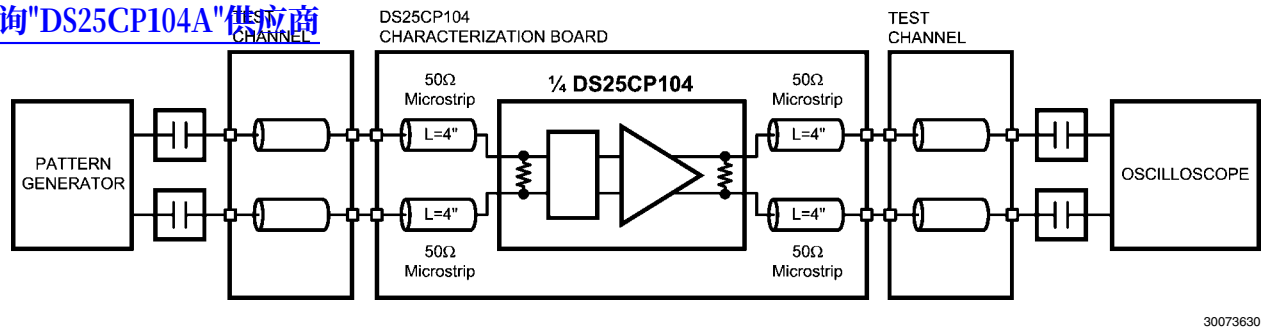


FIGURE 8. Pre-Emphasis and Equalization Performance Test Circuit

Note: DS25CP114 requires external 100Ω input termination.

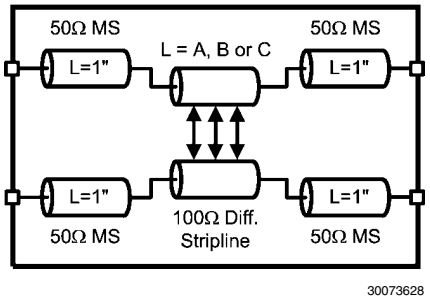


FIGURE 9. Test Channel Block Diagram

Test Channel Loss Characteristics

The test channel was fabricated with Polyclad PCL-FR-370-Laminate/PCL-FRP-370 Prepreg materials (Dielectric constant of 3.7 and Loss Tangent of 0.02). The edge coupled differential striplines have the following geometries: Trace Width (W) = 5 mils, Gap (S) = 5 mils, Height (B) = 16 mils.

Test Channel	Length (inches)	Insertion Loss (dB)					
		500 MHz	750 MHz	1000 MHz	1250 MHz	1500 MHz	1560 MHz
A	10	-1.2	-1.7	-2.0	-2.4	-2.7	-2.8
B	20	-2.6	-3.5	-4.1	-4.8	-5.5	-5.6
C	30	-4.3	-5.7	-7.0	-8.2	-9.4	-9.7
D	15	-1.6	-2.2	-2.7	-3.2	-3.7	-3.8
E	30	-3.4	-4.5	-5.6	-6.6	-7.7	-7.9
F	60	-7.8	-10.3	-12.4	-14.5	-16.6	-17.0

Functional Description

The DS25CP104A and DS25CP114 are 3.125 Gbps 4x4 LVDS digital crosspoint switch optimized for high-speed signal routing and switching over lossy FR-4 printed circuit board backplanes and balanced cables. The DS25CP104A and DS25CP114 operate in two modes: Pin Mode (EN_smb = 0) and SMBus Mode (EN_smb = 1).

When in the Pin Mode, the switch is fully configurable with external pins. This is possible with two input select pins per output (e.g. S00 and S01 pins for OUT0). There is also one transmit pre-emphasis (PE) level select pin per output for switching the PE levels between Medium and Off settings and one receive equalization (EQ) level select pin per input for switching the EQ levels between Low and Off settings.

In the Pin Mode, feedback from the $\overline{\text{LOS}}$ (**L**oss **O**f **S**ignal) monitor circuitry is not available (there is not an $\overline{\text{LOS}}$ output pin).

When in the SMBus Mode, the full switch configuration, four levels of transmit pre-emphasis (Off, Low, Medium and High), four levels of receive equalization (Off, Low, Medium and High) and $\overline{\text{Soft}}\overline{\text{PWDN}}$ can be programmed via the SMBus interface. In addition, by using the SMBus interface, a user can obtain the feedback from the built-in $\overline{\text{LOS}}$ circuitry which detects an open inputs fault condition.

In the SMBus Mode, the S00 and S01 pins become SMBus clock (SCL) input and data (SDA) input pins respectively; the S10, S11, S21 and S21 pins become the User-Set SMBus Slave Address input pins (ADDR0, 1, 2 and 3) while the S30 and S31 pins become non-functional (tieing these two pins to either H or L is recommended if the device will function only in the SMBus mode).

In the SMBus Mode, the PE and EQ select pins as well as the $\overline{\text{PWDN}}$ pin remain functional. How these pins function in each mode is explained in the following sections.

OPERATION IN PIN MODE

Power Up

In the Pin Mode, when the power is applied to the device power suppy pins, the DS25CP104A/DS25CP114 enters the Power Up mode when the $\overline{\text{PWDN}}$ pin is set to logic H. When in the Power Down mode ($\overline{\text{PWDN}}$ pin is set to logic L), all circuitry is shut down except the minimum required circuitry for the $\overline{\text{LOS}}$ and SMBus Slave operation.

Switch Configuration

In the Pin Mode, the DS25CP104A/DS25CP114 operates as a fully pin-configurable crosspoint switch. The following truth tables illustrate how the swich can be configured with external pins.

Switch Configuration Truth Tables

TABLE 1. Input Select Pins Configuration for the Output OUT0

S01	S00	INPUT SELECTED
0	0	IN0
0	1	IN1
1	0	IN2
1	1	IN3

TABLE 2. Input Select Pins Configuration for the Output OUT1

S11	S10	INPUT SELECTED
0	0	IN0
0	1	IN1
1	0	IN2
1	1	IN3

TABLE 3. Input Select Pins Configuration for the Output OUT2

S21	S20	INPUT SELECTED
0	0	IN0
0	1	IN1
1	0	IN2
1	1	IN3

TABLE 4. Input Select Pins Configuration for the Output OUT3

S31	S30	INPUT SELECTED
0	0	IN0
0	1	IN1
1	0	IN2
1	1	IN3

Setting Pre-Emphasis Levels

The DS25CP104A/DS25CP114 has one PE level select pin per output for setting the transmit pre-emphasis to either Medium or Off level. The following is the transmit pre-emphasis truth table.

TABLE 5. Transmit Pre-Emphasis Truth Table

OUTPUT OUTn, n = {0, 1, 2, 3}	
Pre-Emphasis Control Pin (PEn) State	**Pre-Emphasis Level**
0	Off
1	Medium

Transmit Pre-emphasis Level Selection for an Output OUTn

Setting Equalization Levels

The DS25CP104A/DS25CP114 has one EQ level select pin per input for setting the receive equalization to either Low or Off level. The following is the receive equalization truth table.

TABLE 6. Receive Equalization Truth Table

INPUT INn, n = {0, 1, 2, 3}	
Equalization Control Pin (EQn) State	**Equalization Level**
0	Off
1	Low

Receive Equalization Level Selection for an Input INn

OPERATION IN SMBUS MODE

The DS25CP104A/DS25CP114 operates as a slave on the System Management Bus (SMBus) when the EN_smb pin is set to a high (1). Under these conditions, the SCL pin is a clock input while the SDA pin is a serial data input pin.

Device Address

Based on the SMBus 2.0 specification, the DS25CP104A/DS25CP114 has a 7-bit slave address. The three most significant bits of the slave address are hard wired inside the DS25CP104A/DS25CP114 and are “101”. The four least significant bits of the address are assigned to pins ADDR3-ADDR0 and are set by connecting these pins to GND for a low (0) or to VCC for a high (1). The complete slave address is shown in the following table:

TABLE 7. Slave Address

1	0	1	ADDR3	ADDR2	ADDR1	ADDR0
MSB						LSB

This slave address configuration allows up to sixteen DS25CP104A/DS25CP114 devices on a single SMBus bus.

Transfer of Data via the SMBus

During normal operation the data on SDA must be stable during the time when SCK is high.

There are three unique states for the SMBus:

START: A HIGH to LOW transition on SDA while SCK is high indicates a message START condition.

STOP: A LOW to HIGH transition on SDA while SCK is high indicates a message STOP condition.

IDLE: If SCK and SDA are both high for a time exceeding tBUF from the last detected STOP condition or if they are high for a total exceeding the maximum specification for tHIGH then the bus will transfer to the IDLE state.

SMBus Transactions

A transaction begins with the host placing the DS25CP104A SMBus into the START condition, then a byte (8 bits) is transferred, MSB first, followed by a ninth ACK bit. ACK bits are ‘0’ to signify an ACK, or ‘1’ to signify NACK, after this the host holds the SCL line low, and waits for the receiver to raise the SDA line as an ACKnowledge that the byte has been received.

Writing to a Register

To write a register, the following protocol is used (see SMBus 2.0 specification):

1) The Host drives a START condition, the 7-bit SMBus address, and a “0” indicating a WRITE.

2) The Device (Slave) drives an ACK bit (“0”).

3) The Host drives the 8-bit Register Address.

4) The Device drives an ACK bit (“0”).

5) The Host drives the 8-bit data byte.

6) The Device drives an ACK bit “0”.

7) The Host drives a STOP condition.

The WRITE transaction is completed, the bus goes Idle and communication with other SMBus devices may now occur.

Reading From a Register

To read a register, the following protocol is used (see SMBus 2.0 specification):

1) The Host drives a START condition, the 7-bit SMBus address, and a “0” indicating a WRITE.

2) The Device (Slave) drives an ACK bit (“0”).

3) The Host drives the 8-bit Register Address.

4) The Device drives an ACK bit (“0”).

5) The Host drives a START condition.

6) The Host drives the 7-bit SMBus Address, and a “1” indicating a READ.

7) The Device drives an ACK bit “0”.

8) The Device drives the 8-bit data value (register contents).

9) The Host drives a NACK bit “1” indicating end of READ transfer.

10) The Host drives a STOP condition.

The READ transaction is completed, the bus goes Idle and communication with other SMBus devices may now occur.

Register Descriptions

There are five data registers in the DS25CP104A/DS25CP114 accessible via the SMBus interface.

TABLE 8. SMBus Data Registers

Address (hex)	Name	Access	Description
0	Switch Configuration	R/W	Switch Configuration Register
1	PE Level Select	R/W	Transmit Pre-emphasis Level Select Register
2	EQ Level Select	R/W	Receive Equalization Level Select Register
3	Control	R/W	Powerdown, $\overline{LOS}$ Enable and Pin Control Register
4	$\overline{LOS}$	RO	**L**oss **O**f **S**ignal ($\overline{LOS}$) Reporting Register

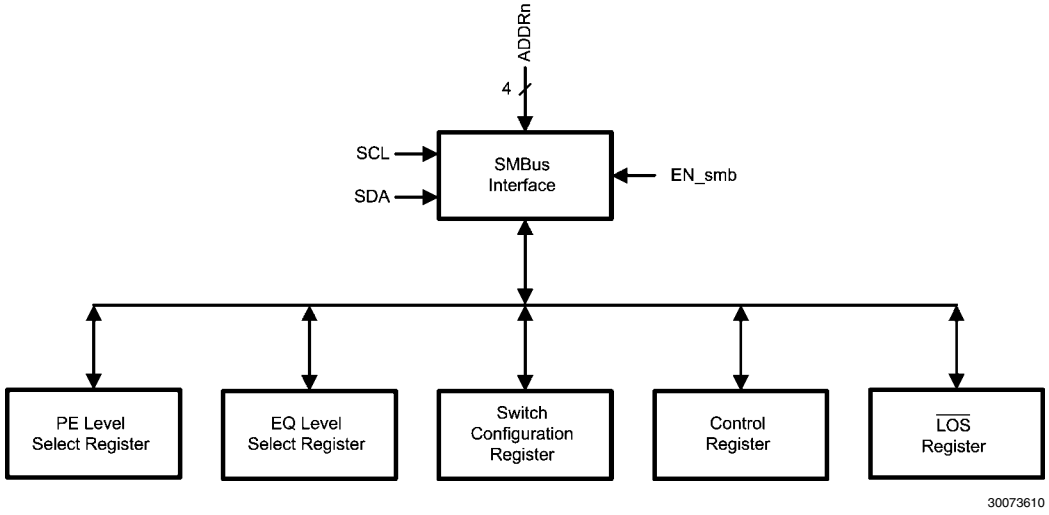


FIGURE 10. Registers Block Diagram

SWITCH CONFIGURATION REGISTER

The Switch Configuration register is utilized to configure the switch. The following two tables show the Switch Configuration Register mapping and associated truth table.

Bit	Default	Bit Name	Access	Description
D[1:0]	00	Input Select 0	R/W	Selects which input is routed to the OUT0.
D[3:2]	00	Input Select 1	R/W	Selects which input is routed to the OUT1.
D[5:4]	00	Input Select 2	R/W	Selects which input is routed to the OUT2.
D[7:6]	00	Input Select 3	R/W	Selects which input is routed to the OUT3.

TABLE 9. Switch Configuration Register Truth Table

D1	D0	Input Routed to the OUT0
0	0	IN0
0	1	IN1
1	0	IN2
1	1	IN3

The truth tables for the OUT1, OUT2, and OUT3 outputs are identical to this table.

The switch configuration logic has a SmartPWDN circuitry which automatically optimizes the device's power consumption based on the switch configuration (i.e. It places unused I/O blocks and other unused circuitry in the power down state).

PE LEVEL SELECT REGISTER

The PE Level Select register selects the pre-emphasis level for each of the outputs. The following two tables show the register mapping and associated truth table.

Bit	Default	Bit Name	Access	Description
D[1:0]	00	PE Level Select 0	R/W	Sets pre-emphasis level on the OUT0.
D[3:2]	00	PE Level Select 1	R/W	Sets pre-emphasis level on the OUT1.
D[5:4]	00	PE Level Select 2	R/W	Sets pre-emphasis level on the OUT2.
D[7:6]	00	PE Level Select 3	R/W	Sets pre-emphasis level on the OUT3.

TABLE 10. PE Level Select Register Truth Table

D1	D0	Pre-Emphasis Level for the OUT0
0	0	Off
0	1	Low
1	0	Medium
1	1	High

NOTE: The truth tables for the OUT1, OUT2, and OUT3 outputs are identical to this table.

EQ LEVEL SELECT REGISTER

The EQ Level Select register selects the equalization level for each of the inputs. The following two tables show the register mapping and associated truth table.

Bit	Default	Bit Name	Access	Description
D[1:0]	00	EQ Level Select 0	R/W	Sets equalization level on the IN0.
D[3:2]	00	EQ Level Select 1	R/W	Sets equalization level on the IN1.
D[5:4]	00	EQ Level Select 2	R/W	Sets equalization level on the IN2.
D[7:6]	00	EQ Level Select 3	R/W	Sets equalization level on the IN3.

TABLE 11. EQ Level Select Register Truth Table

D1	D0	Equalization Level for the IN0
0	0	Off
0	1	Low
1	0	Medium
1	1	High

NOTE: The truth tables for the IN1, IN2, and IN3 outputs are identical to this table.

CONTROL REGISTER

The Control register enables SoftPWDN control, individual output power down (PWDNn) control, LOS Circuitry Enable control, PE Level Select Enable control and EQ Level Select Enable control via the SMBus. The following table shows the register mapping.

Bit	Default	Bit Name	Access	Description
D[3:0]	1111	PWDNn	R/W	Writing a [0] to the bit D[n] will power down the output OUTn when either the PWDN pin OR the Control Register bit D[7] (SoftPWDN) is set to a high [1].
D[4]	0	Ignore_External_EQ	R/W	Writing a [1] to the bit D[4] will ignore the state of the external EQ pins and will allow setting the EQ levels via the SMBus interface.
D[5]	0	Ignore_External_PE	R/W	Writing a [1] to the bit D[5] will ignore the state of the external PE pins and will allow setting the PE levels via the SMBus interface.
D[6]	0	EN_LOS	R/W	Writing a [1] to the bit D[6] will enable the LOS circuitry and receivers on all four inputs. The SmartPWDN circuitry will not disable any of the inputs nor any supporting LOS circuitry depending on the switch configuration.
D[7]	0	SoftPWDN	R/W	Writing a [0] to the bit D[7] will place the device into the power down mode. This pin is ORed together with the PWDN pin.

TABLE 12. Power Modes Truth Table

PWDN	SoftPWDN	PWDNn	Power Mode
0	0	x	Power Down Mode. In this mode, all circuitry is shut down except the minimum required circuitry for the LOS and SMBus Slave operation. The SMBus circuitry allows enabling the LOS circuitry and receivers on all inputs in this mode by setting the EN_LOS bit to a [1].
0 1 1	1 0 1	x x x	Power Up Mode. In this mode, the SmartPWDN circuitry will automatically power down any unused I/O and logic blocks and other supporting circuitry depending on the switch configuration. An output will be enabled **only** when the SmartPWDN circuitry indicates that that particular output is needed for the particular switch configuration **and** the respective PWDNn bit has logic high [1]. An input will be enabled when the SmartPWDN circuitry indicates that that particular input is needed for the particular switch configuration **or** the EN_LOS bit is set to a [1].

LOS REGISTER

The LOS register reports an open inputs fault condition for each of the inputs. The following table shows the register mapping.

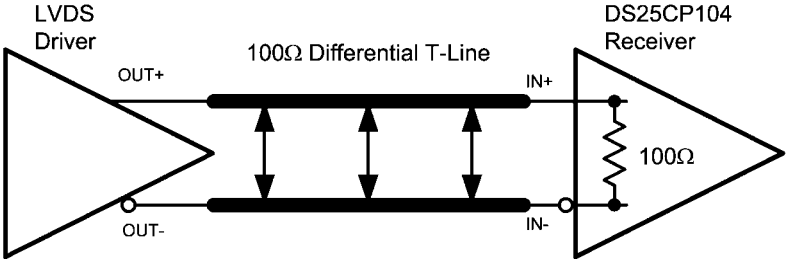
Bit	Default	Bit Name	Access	Description
D[0]	0	LOS0	RO	Reading a [0] from the bit D[0] indicates an open inputs fault condition on the IN0. A [1] indicates presence of a valid signal.
D[1]	0	LOS1	RO	Reading a [0] from the bit D[1] indicates an open inputs fault condition on the IN1. A [1] indicates presence of a valid signal.
D[2]	0	LOS2	RO	Reading a [0] from the bit D[2] indicates an open inputs fault condition on the IN2. A [1] indicates presence of a valid signal.
D[3]	0	LOS3	RO	Reading a [0] from the bit D[3] indicates an open inputs fault condition on the IN3. A [1] indicates presence of a valid signal.
D[7:4]	0000	Reserved	RO	Reserved for future use. Returns undefined value when read.

INPUT INTERFACING

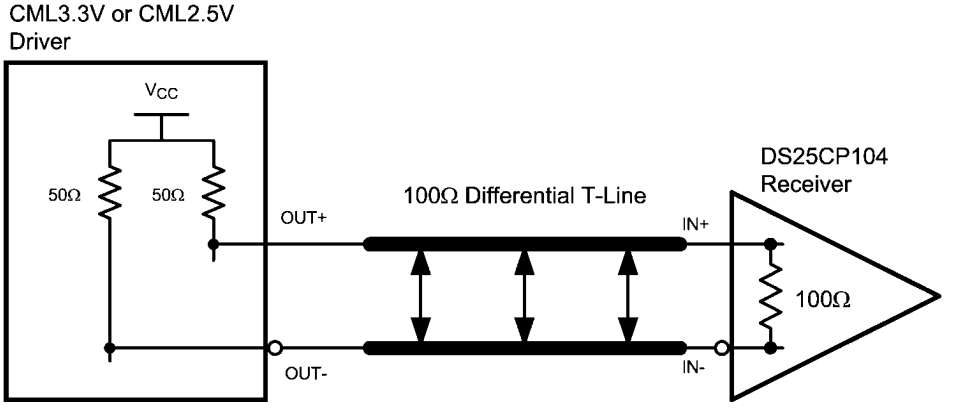
The DS25CP104A/DS25CP114 accepts differential signals and allows simple AC or DC coupling. With a wide common mode range, the DS25CP104A/DS25CP114 can be DC-coupled with all common differential drivers (i.e. LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers.

The DS25CP104A inputs are internally terminated with a 100Ω resistor for optimal device performance, reduced component count, and minimum board space. External input terminations on the DS25CP114 need to be placed as close as possible to the device inputs to achieve equivalent AC performance. When all four inputs are utilized it may be necessary to alternate between the top and bottom layers to achieve the minimum device input to termination distance. It is recommended that SMT resistors sized 0402 or smaller be used and the mounting distance to the DS25CP114 pins kept under 200 mils.

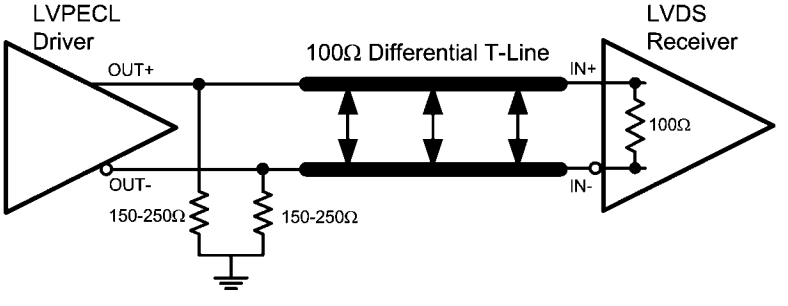
When using the DS25CP114 in a limited multi-drop topology, any transmission line stubs should be kept very short to minimize any negative effects on signal quality. A single termination resistor or resistor network that matches the differential line impedance should be used. If DS25CP114 input pairs from two separate devices are to be connected to a single differential output, it is recommended that the DS25CP114 devices are mounted directly opposite of each other. One on top of the PCB and the other directly under the first on the bottom of the PCB, this keeps the distance between inputs equal to the PCB thickness.



Typical LVDS Driver DC-Coupled Interface to DS25CP104A Input



Typical CML Driver DC-Coupled Interface to DS25CP104A Input

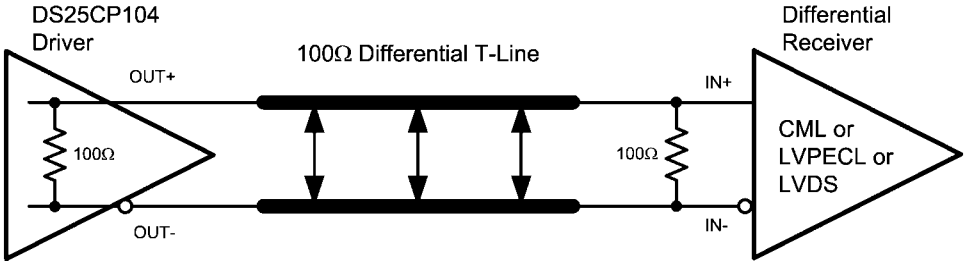


Typical LVPECL Driver DC-Coupled Interface to DS25CP104A Input

Note: DS25CP114 requires external 100Ω input termination.

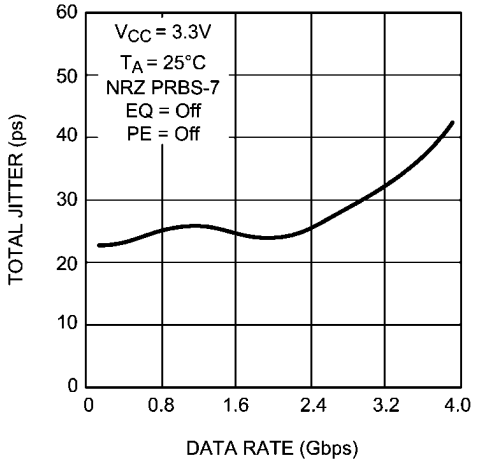
OUTPUT INTERFACING

The DS25CP104A/DS25CP114 outputs signals that are compliant to the LVDS standard. Its outputs can be DC-coupled to most common differential receivers. The following figure illustrates typical DC-coupled interface to common differential receivers and assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accomodate LVDS compliant signals, it is recommended to check respective receiver's data sheet prior to implementing the suggested interface implementation.



Typical Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver

Typical Performance Characteristics



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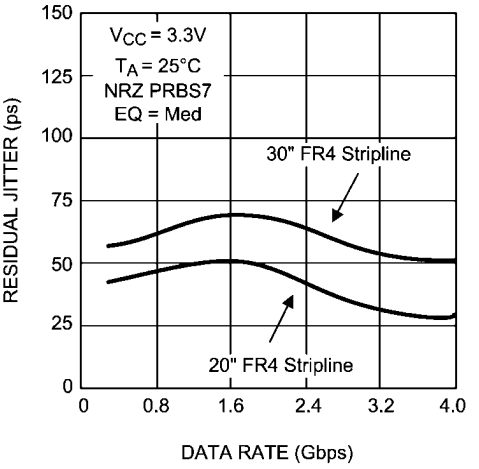
Total Jitter as a Function of Data Rate



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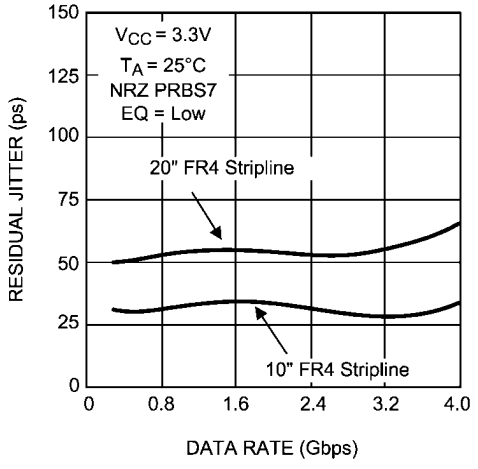
Residual Jitter as a Function of Data Rate, FR4 Stripline Length and EQ Level



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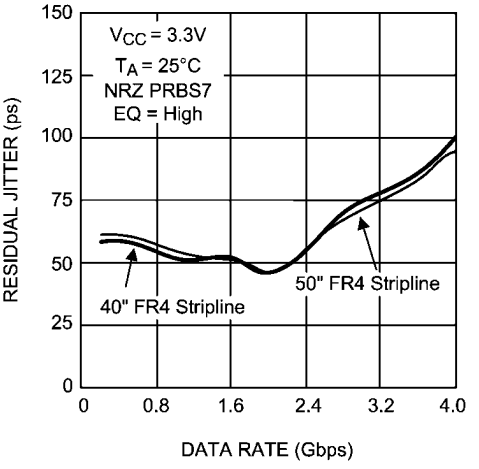
Residual Jitter as a Function of Data Rate, FR4 Stripline Length and EQ Level



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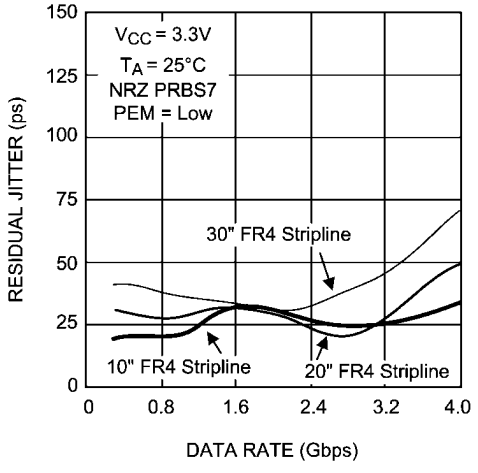
Residual Jitter as a Function of Data Rate, FR4 Stripline Length and EQ Level



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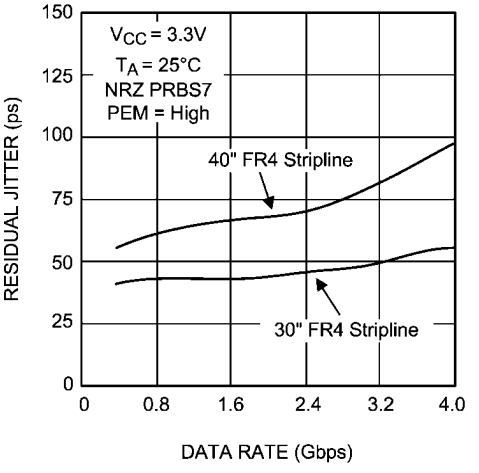
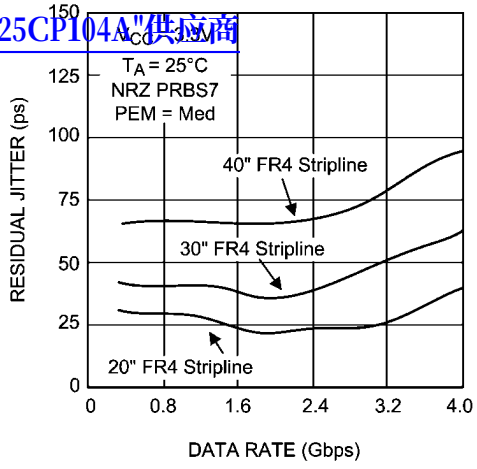
Residual Jitter as a Function of Data Rate, FR4 Stripline Length and PE Level



30073656

Residual Jitter as a Function of Data Rate, FR4 Stripline Length and PE Level



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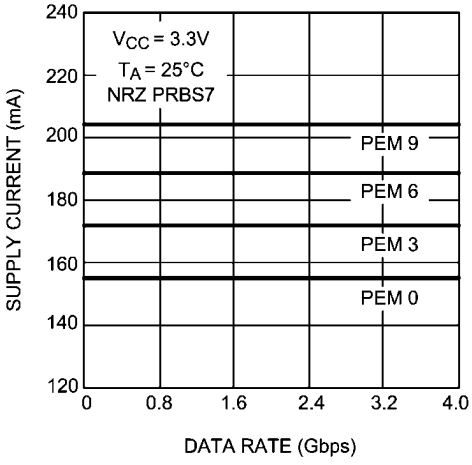
Residual Jitter as a Function of Data Rate, FR4 Stripline Length and PE Level



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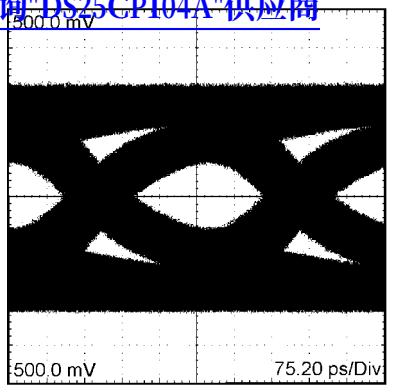
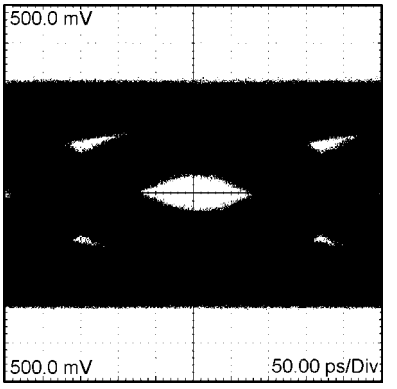
Supply Current as a Function of Data Rate and PE Level

Typical Performance



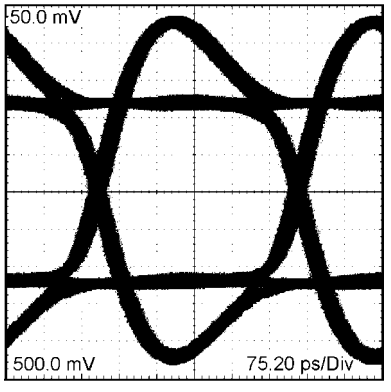
30073662

A 2.5 Gbps NRZ PRBS-23 without PE
After 30" Differential FR-4 Stripline
H: 75 ps / DIV, V: 100 mV / DIV



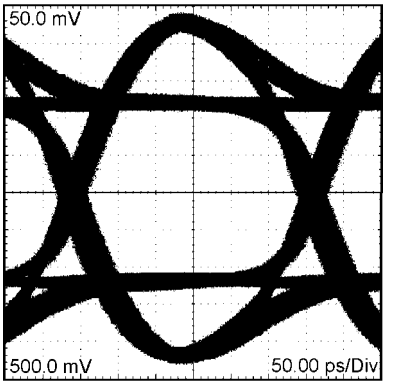
30073663

A 3.125 Gbps NRZ PRBS-23 without PE
After 30" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV



30073660

A 2.5 Gbps NRZ PRBS-23 with High PE
After 2" Differential FR-4 Microstrip
H: 75 ps / DIV, V: 100 mV / DIV



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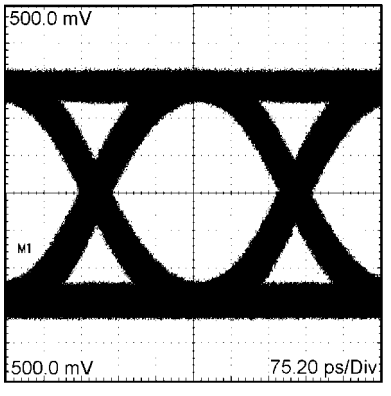
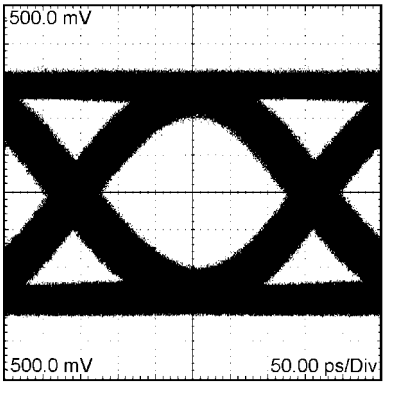
A 3.125 Gbps NRZ PRBS-23 with High PE
After 2" Differential FR-4 Microstrip
H: 50 ps / DIV, V: 100 mV / DIV



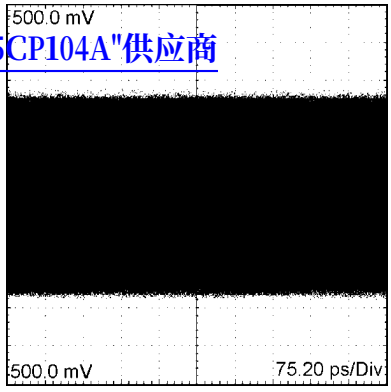
30073664

A 2.5 Gbps NRZ PRBS-23 with High PE
After 30" Differential FR-4 Stripline
H: 75 ps / DIV, V: 100 mV / DIV



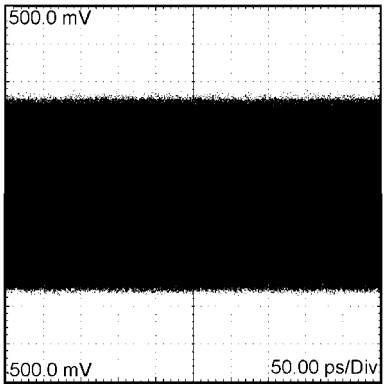
30073665

A 3.125 Gbps NRZ PRBS-23 with High PE
After 30" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV



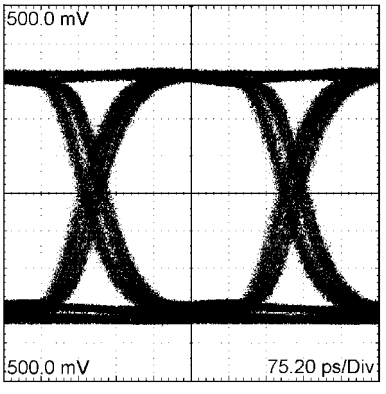
30073666

A 2.5 Gbps NRZ PRBS-23 without EQ
After 60" Differential FR-4 Stripline
H: 75 ps / DIV, V: 100 mV / DIV



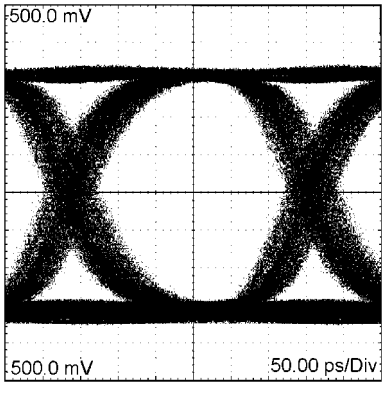
30073667

A 3.125 Gbps NRZ PRBS-23 without EQ
After 60" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV



30073668

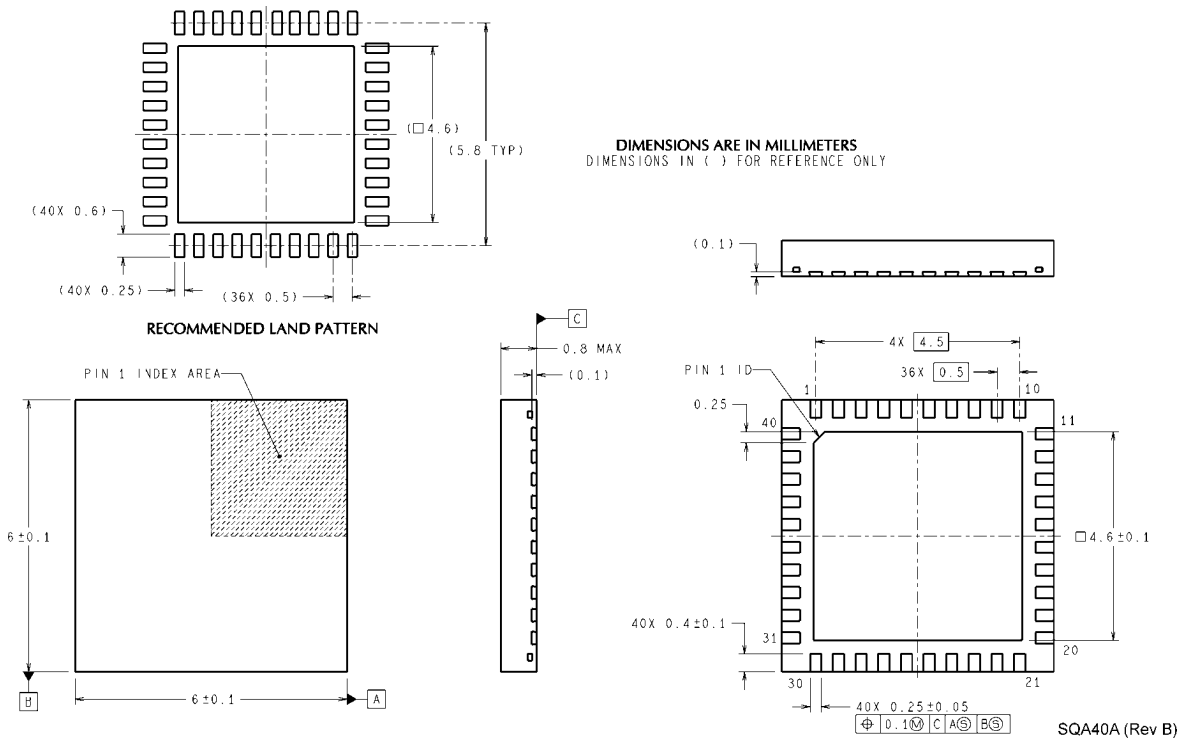
A 2.5 Gbps NRZ PRBS-23 with High EQ
After 60" Differential FR-4 Stripline
H: 75 ps / DIV, V: 100 mV / DIV



30073669

A 3.125 Gbps NRZ PRBS-23 with High EQ
After 60" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV

Physical Dimensions inches (millimeters) unless otherwise noted



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NS Package Number SQA40A
(See AN-1187 for PCB Design and Assembly Recommendations)

Notes

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